SID1102K SCALE-iDriver Family

Up to 5 A Single Channel IGBT/MOSFET Gate Driver Providing Reinforced Galvanic Isolation up to 1200 V Blocking Voltage

Product Highlights

Highly Integrated, Compact Footprint

- Single channel providing up to 5 A peak gate drive current
- Auxiliary outputs for external booster stage for increased peak drive current
- Integrated FluxLink™ technology providing safe isolation between primary-side and secondary-side
- Rail-to-rail stabilized output voltage
- Unipolar supply voltage for secondary-side
- Suitable for 600 V / 650 V / 1200 V IGBT and MOSFET switches
- Up to 75 kHz switching frequency
- Propagation delay jitter ± 5 ns
- \cdot -40 °C to 125 °C operating ambient temperature
- High common-mode transient immunity
- eSOP package with 9.5 mm creepage and clearance

Protection / Safety Features

• Undervoltage lock-out protection for primary and secondary-side (UVLO)

Full Safety and Regulatory Compliance

- 100% production partial discharge test
- 100% production HIPOT compliance testing at 6 kV RMS 1 s
- Reinforced insulation meets VDE V 0884-10

Green Package

• Halogen free and RoHS compliant

Applications

- General purpose and servo drives
- UPS, solar, welding inverters and power supplies Figure 2. eSOP-R16B Package.

Description

The SID1102K is a single channel IGBT and MOSFET gate driver in an eSOP package. Reinforced galvanic isolation is provided by Power Integrations' revolutionary solid insulator FluxLink technology. Up to 5 A peak output drive current enables the product to drive devices with nominal currents of up to 300 A. For gate drive requirements that exceed the stand-alone capability of SID1102K, additionally AUXGL and AUXGH output pins can drive external n-channel MOSFETs as a booster stage, giving customers full freedom and control of their system design.

Controller (PWM) signals are compatible with 5 V CMOS logic, which may also be adjusted to 15 V levels by using external resistor divider.

Product Portfolio

Notes: 1. Package: eSOP-R16B.

Figure 1. Typical Application Schematic with External n-Channel MOSFET Booster Stage.

SID1102K

Figure 3. Functional Block Diagram.

Pin Functional Description

VCC Pin (Pin 1)

This pin is the primary-side supply voltage connection.

GND Pin (Pin 3-6)

This pin is the connection for the primary-side ground potential. All primary-side voltages refer to the pin.

IN Pin (Pin 7)

This pin is the input for the logic command signal.

NC Pins (Pin 8, Pin 9)

These pins must be un-connected. Minimum PCB pad size for soldering is required.

VEE Pin (Pin 10)

Common (IGBT emitter/MOSFET source) output supply voltage.

AUXGH Pin (Pin 11)

This pin is the high side driver signal for external n-channel MOSFET booster stage.

VGXX Pin (Pin 12)

This pin is the bootstrap and charge pump supply voltage source.

G Pin (Pin 13)

This pin is the driver output (turn-on/turn-off) connection.

VISO Pin (Pin 14)

This pin is the input for the secondary-side positive supply voltage.

COM Pin (Pin 15)

This pin provides the secondary-side reference potential.

AUXGL Pin (Pin 16)

This pin is the low side driver signal for external n-channel MOSFET booster stage.

SCALE-iDriver Functional Description

The single channel SCALE-iDriver™ SID1102K drives IGBTs and MOSFETs or other semiconductor power switches with a blocking voltage of up to 1200 V and provides reinforced isolation between micro-controller and the power semiconductor switch.

Command signals are transferred from the primary (IN) to secondary-side via FluxLink isolation technology. The G pin supplies a positive gate voltage and charges the semiconductor gate during the turn-on process. During the turn-off process the G pin supplies the negative voltage and discharges the gate.

SID1102K

Additionally, dedicated AUXGL and AUXGH output pins are available to drive external n-channel MOSFETs as booster stage that can be configured to provide increased peak output gate drive current.

Power Supplies

The SID1102K requires two power supplies. One for the primary-side (V_{vcc}) , which powers the primary-side logic and communication with the secondary (insulated) side. The other supply voltage (V_{TOT}) is required for the secondary-side. V_{tot} is applied between VISO pin and COM pin. V_{TOT} should be insulated from the primary-side and should provide at least the same insulation capabilities as the SCALE-iDriver. V_{TOT} should have a low capacitive coupling to the primary or any other secondary-side. The positive gate-emitter source voltage is provided by V_{VISO} , which is internally generated and stabilized to 15 V (typically) with respect to VEE. The negative gate-emitter source voltage is provided by VEE with respect to COM. Due to the limited current sourcing/sinking capabilities of the VEE pin, any additional load needs to be applied between the VISO and COM pins. No additional load between VISO and VEE pins or between VEE and COM pins is allowed.

Input (Primary-Side)

The input (IN) logic is designed to work directly with micro-controllers using 5 V CMOS logic. If the physical distance between the controller and the SCALE-iDriver is large or if a different logic level is required, the resistive divider in Figure 6 is recommended. This solution adjusts the logic level as necessary and will also improve the driver's noise immunity.

Gate driver commands are transferred from the IN pin to the G pin with a propagation delay $t_{P(LH)}$ and $t_{P(HL)}$.

Output (Secondary-Side)

The gate of the power semiconductor switch should be connected to the SCALE-iDriver output via pin G, using suitable gate resistor R_G as shown in Figure 7.

Note that most power semiconductor data sheets specify an internal gate resistor $R_{\text{\tiny GINT}}$, which is already integrated into power semiconductor switch. In addition to R_{GINT} external resistor device R_{G} is specified to set-up the gate current level to the application requirements. Careful consideration should be given to the power dissipation and peak current associated with the external gate resistor.

The G pin output current source (I_{G(H)}, I_{G(L)}) of SID1102K is capable of sinking and sourcing (typically) 5 A at 25 °C. The SCALE-iDriver's internal resistances are described as R_{GHI} and R_{GLI} respectively. If the gate resistor attempts to draw a higher peak current, the peak current will be internally limited to a safe value.

Safe Power-Up and Power-Down

It is recommended during power-up and power-down that the IN pin stays at logic low. Any supply voltage related to VCC, VISO, VEE and VGXX pins should be stabilized using ceramic capacitors $\mathsf{C}_{_{1}}$, $\mathsf{C}_{_{2}}$, $\mathsf{C}_{_{\mathsf{S1'}}}$ C_{S2} , and C_{GXX} respectively as shown in Figure 5 and Figure 7. After supply voltages reach their nominal values, the driver will begin to function after a time delay t_{START} .

Short-Pulse Operation

If command signals applied to the IN pin are shorter than the minimum specified by $t_{GE(MIN)}$, then SID1102K output signals at G, AUXGH, and AUXGL pins will extend to value $t_{\text{GE(MIN)}}$. The duration of pulses longer than $t_{\text{GE(MIN)}}$ will not be changed.

Figure 5. Recommended Circuitry for Standard 5 V IN Logic Level.

Figure 6. Recommended Circuitry for Increased IN Logic Levels. For R, = 3.3 kΩ and R, = 1 kΩ the IN Logic Level is 15 V.

Figure 7. SID1102K without External Booster Stage.

Application Example and Components Selection Without Booster

Figure 5 and Figure 7 show the primary-side and secondary-side schematic and typical components used for SID1102K design without a booster stage, in which the primary-side supply voltage (V_{vcc}) will be connected between VCC and GND pins and supported through supply bypass ceramic capacitors $\mathsf{C}_\text{\tiny{1}}$ (4.7 μ F typically) and $\mathsf{C}_\text{\tiny{2}}$ (470 nF typically). If the command signal voltage level is higher than the rated IN pin voltage, a resistive voltage divider should be used (Figure 6). Additional capacitor C_{ϵ} can be used to provide input signal filtering as shown in Figure 8. The filter time τ can be calculated according to equation (1):

$$
\tau = \frac{R_1 \times R_2}{R_1 + R_2} \times C_F \tag{1}
$$

Figure 8. Optional Input Signal Filtering.

The secondary-side isolated power supply (V_{TOT}) is connected between VISO and COM. The positive voltage rail (V_{VISO}) is supported through ceramic capacitor C_{S1} . The negative voltage rail (V_{VEE}) is similarly supported through capacitor C_{S2} . Typically, C_{S1} and C_{S2} should be at least 3μ F multiplied by the total gate charge of the power semiconductor switch (Q_{GATE}) divided by 1 μ C. A 10 nF capacitor C_{GXX} is connected between the G and VGXX pins.

To ensure gate voltage stabilization and collector current limitation during short-circuit the gate is connected to V_{VISO} through Schottky diode D_{STO} .

To avoid parasitic power-switch-conduction during system power-on the gate is connected to COM through 22 k Ω resistor $\mathsf{R}_{\mathfrak{z}}$ as shown in Figure 7.

Gate resistors are located physically close to the power semiconductor switch. As these components can get hot, it is recommended that they are placed away from the SCALE-iDriver.

Application Example and Components Selection With Booster

The primary-side can be setup identical as described in the previous section refering to Figure 5 or Figure 6 or Figure 8.

The secondary-side is slightly extended by the booster MOSFETs $T₁$ and T_{2} (BSO220N03MD G for example) and the addition of discrete gate resistors $\mathsf{R}_{_{\mathsf{GON}}}$ and $\mathsf{R}_{_{\mathsf{GOFF}}}$ as well as diode $\mathsf{D}_{_{\mathsf{2}}}$ (PMEG4010CEJ for example). All other components can be kept, values might be adapted to the relevant target power semiconductor switching device, such as gate resistors and the supply bypass capacitors C_{s1} , C_{s2} .

Figure 9. SID1102K with External Boosterstage.

In Off-state (VIN = 0 V) the AUXGL pin provides a positive voltage to the gate terminal of ${\sf T}_2$ with reference to the MOSFETs source potential e.g. COM. T_{2} conducts the semiconductors gate terminal to COM via R_{GOFF} providing a negative voltage with reference to VEE to the semiconductors gate (IGBT in this case). The power semiconductor device is off.

When VIN changes from 0 V to 5 V, ${\mathsf T}_2$ is turned off by applying 0 V to the AUXGL pin with reference to COM. At the same time ${\sf T}_{_1}$ is turned on by providing a positive gate voltage via AUXGH to the gate of T₁ with reference to G. Since the G pin is connected to V_{TOT} in On-state, the potential of the AUXGH pin needs to be higher than V_{TOT} . This is achieved via SCALE-iDriver's internal charge pump / bootstrap. When $\mathsf{T}_\mathtt{i}$ conducts, it provides a positive gate voltage to the power semiconductors gate with reference to VEE. The power semiconductor device is on.

When VIN changes from 5 V to 0 V, it has to be considered, that R_{GON} and $\rm R_{\rm GOFF}$ are paralleled, consequently resulting in a $\rm R_{\rm GOFF}$ < $\rm R_{\rm GON}$ for all chosen. $\ R_{_{\rm G}}$ is placed in series to $\rm R_{_{GON}}$ to allow $\rm R_{_{GOF}}$ > $\rm R_{_{GON}}$.

To ensure that no parasitic turn-on of the power semiconductor switching device occurs when used on the high-side of a half-bridge topology and under worst case switching conditions, the use of the Schottky diode D_{2} (PMEG4010CEJ for example) is recommended.

Since the current capability of the VGXX pin is limited, it is recommended to restrict the applicable external N-Channel Booster MOSFETs to those with a gate charge $Q_{\rm G} \leq 9~$ nC for $T_{\rm 1}$ and $Q_{G} \leq 5$ nC for T_{2} .

Figure 10. Exemplary Schematic without Booster.

Figure 11. Exemplary Schematic with Booster.

Power Dissipation and IC Junction Temperature Estimation

The following scheme is valid for the SCALE-iDriver without external booster stage. With external booster stage, the majority of losses will be consumed by the MOSFETs of the booster.

First calculation in designing the power semiconductor switch gate driver stage is to calculate the required gate power P_{DRV} . The power is calculated based on equation (2):

$$
P_{DRV} = Q_{GATE} \times f_S \times V_{TOT}
$$
 (2)

where,

 Q_{GATE} – Controlled power semiconductor switch gate charge (derived for the particular gate potential range defined by V_{tot}). See semiconductor manufacturer data sheet.

 $f_{\rm s}$ – Switching frequency which is the same as applied to the IN pin of SCALE-iDriver.

 V_{TOT} – SCALE-iDriver secondary-side supply voltage.

In addition to P_{DRV}, P_P (primary-side IC power dissipation) and P_{SNL}
(secondary-side IC power dissipation without capacitive load) must be considered. Both are ambient temperature and switching frequency dependent (see typical performance characteristics).

$$
P_P = V_{VCC} \times I_{VCC}
$$

\n
$$
P_{SNL} = V_{TOT} \times I_{VISO}
$$
\n(3)

During operation, the P_{DRV} power is shared between the external gate resistor R_{G} , the internal gate resistor R_{GINT} , of the power switch (if available) and internal driver resistances R_{GHI} and R_{GLI} . For junction temperature estimation purposes, the dissipated power under load (P_{α}) inside the IC can be calculated according to equation (5):

$$
P_{OL} = 0.5 \times Q_{CATE} \times f_S \times V_{TOT} \times
$$

$$
\left(\frac{R_{GHI}}{R_{GHI} + R_{CX}} + \frac{R_{GLI}}{R_{GLI} + R_{CX}}\right)
$$
(5)

 R_{cx} represents the sum of external (R_{c}) and power semiconductor internal gate resistance (R_{GINT}) :

$$
R_{\scriptscriptstyle{GX}} = R_{\scriptscriptstyle{G}} + R_{\scriptscriptstyle{GINT}} \tag{6}
$$

Total power dissipation (P_{DIS}) is estimated as sum of equations (3), (4) and (5):

$$
P_{\text{DIS}} = P_{\text{P}} + P_{\text{SNL}} + P_{\text{OL}} \tag{7}
$$

The operating junction temperature $\mathsf{(\mathsf{T}_j)}$ for given ambient temperature (T_a) can be estimated according to equation (8):

$$
T_J = \theta_{JA} \times P_{DIS} + T_A \tag{8}
$$

Table 2 describes the recommended component characteristics and layout requirements to achieve optimum performances of SCALE-iDriver without external n-channel MOSFET booster.

Table 2. PCB Layout and Component Guidelines without External n-Channel MOSFET Booster.

Table 3 describes the recommended component characteristics and layout requirements to achieve optimum performances of SCALE-iDriver with external n-channel MOSFET booster.

Table 3. PCB Layout and Component Guidelines with External n-Channel MOSFET Booster.

Table 3. PCB Layout and Component Guidelines with External n-Channel MOSFET Booster (cont.).

NOTES:

1. Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device.

2. Defined as peak voltage measured directly on VCC pin.

3. Transmission of command signals could be affected by PCB layout parasitic inductances at junction temperatures higher than recommended.

4. Input Power Dissipation refers to equation (3). Output Power Dissipation is secondary-side IC power dissipation without capacitive load $(P_{\text{SNL}}$, equation (4)) and dissipated power under load (P_{OL} , equation (5)). Total IC power dissipation is sum of P_p and P_{S} .

Thermal Resistance

Notes:

1. 2 oz. (610 g/m^2) copper clad.

2. The case temperature is measured at the plastic surface at the top of the package.

Figure 12. Thermal Derating Curve Showing Dependence of Limited Dissipated Power on Case Temperature (DIN V VDE V 0884-10).

Operation is allowed until T_J and/or T_c of 125 °C are reached. Thermal stress beyond those values but below thermal derating curve may lead to permanent functional product damage. Operating beyond thermal SOP derating curve may affect product reliability.

NOTES:

- 1. $V_{\text{vcc}} = 5$ V, $V_{\text{TOT}} = 25$ V. $R_{\text{G}} = 5.6 \Omega$, no C_{G} , without external booster stage. The VGXX pin is connected to the G pin through a 10 nF capacitor. Typical values are defined at T_A = 25 °C; f_s = 20 kHz, Duty Cycle = 50%. Positive currents are assumed to be flowing into pins.
- 2. Pulse width ≤ 10 μs, duty cycle ≤ 1%. The maximum value is controlled by the ASIC to a safe level. The internal peak power is safely controlled for $R_c \ge 0$ and power semiconductor module input gate capacitance $C_{\text{res}} \le 47$ nF.
- 3. V_{IN} potential changes from 0 V to 5 V within 10 ns. Delay is measured from 50% voltage increase on IN pin to 10% voltage increase on G pin.
- 4. V_{IN} potential changes from 5 V to 0 V within 10 ns. Delay is measured from 50% voltage decrease on IN pin to 10% voltage decrease on G pin.
- 5. Measured from 10% to 90% of V_{GE} (C_G simulates semiconductor gate capacitance). The V_{GE} is measured across C_G.
- 6. Measured from 90% to 10% of V_{GE} (C_G simulates semiconductor gate capacitance). The V_{GE} is measured across C_G.
- 7. The amount of time after primary and secondary-side supply voltages (V_{vcc} and $V_{\tau \text{OT}}$) reach minimal required level for driver proper operation. No signal is transferred from primary to secondary-side during that time.
- 8. Guaranteed by design.
- 9. Positive current is flowing out of the pin.
- 10. Safety distances are application dependent and the creepage and clearance requirements should follow specific equipment isolation standards of an application. Board design should ensure that the soldering pads of an IC maintain required safety relevant distances.
- 11. Measured accordingly to IEC 61000-4-8 (f_s = 50 Hz, and 60 Hz) and IEC 61000-4-9.
- 12. All pins on each side of the barrier tied together creating a two-terminal device.

Typical Performance Characteristics

Figure 13. Supply Current Primary-Side I $_{\mathrm{vec}}$ vs. Ambient Temperature. Conditions: V_{vcc} = 5 V, V_{tot} = 25 V, No-Load.

Ambient Temperature (°C)

Figure 14. Supply Current Secondary-Side I_{vIso} vs. Ambient Temperature Conditions: V $_{\rm{vec}}$ = 5 V, V $_{\rm{tot}}$ = 25 V, No-Load.

Figure 16. VEE Sink Capability I_{vee(sp} vs. Ambient Temperature and V_{TOT}.
Conditions: V_{vcc} = 5 V, f_s = 20 kHz, Duty Cycle = 50%.

 MSL Table

ESD and Latch-Up Table

IEC 60664-1 Rating Table

Electrical Characteristics (EMI) Table Parameter Symbol Conditions Min Typ Max Units Common-Mode Transient Immunity, Logic High CM_H Typical values measured according to Figure 17 and Figure 18. Maximum values are design values assuming trapezoid waveforms. $-35 / 50$ $-100 / 100$ kV/ μ s **Common-Mode Transient Immunity, Logic Low** CM_L Typical values measured according to Figure 17 and Figure 18. Maximum values are design values assuming trapezoid waveforms. $-35 / 50$ $-100 / 100$ kV/ μ s **Variable Magnetic Field Immunity** H_{HPEAK} See Note 11 1000 A/m H_{LPEAK} See Note 11 1000

Regulatory Information Table

Part Ordering Information

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Power Integrations Worldwide Sales Support Locations

World Headquarters

5245 Hellyer Avenue San Jose, CA 95138, USA Main: +1-408-414-9200 Customer Service: Worldwide: +1-65-635-64480 Americas: +1-408-414-9621 e-mail: usasales@power.com

China (Shanghai)

Rm 2410, Charity Plaza, No. 88 North Caoxi Road Shanghai, PRC 200030 Phone: +86-21-6354-6323 e-mail: chinasales@power.com

China (Shenzhen)

17/F, Hivac Building, No. 2, Keji Nan Bangalore-560052 India 8th Road, Nanshan District, Shenzhen, China, 518057 Phone: +86-755-8672-8689 e-mail: chinasales@power.com

Germany (AC-DC/LED Sales) Lindwurmstrasse 114 D-80337 München Germany Phone: +49-89-5527-39100 e-mail: eurosales@power.com

e-mail: igbt-driver.sales@power.com e-mail: japansales@power.com **Germany** (Gate Driver Sales) HellwegForum 1 59469 Ense Germany Tel: +49-2938-64-39990

India

#1, 14th Main Road Vasanthanagar Phone: +91-80-4113-8020 e-mail: indiasales@power.com

Italy

Via Milanese 20, 3rd. Fl. 20099 Sesto San Giovanni (MI) Italy Phone: +39-024-550-8701 e-mail: eurosales@power.com

Japan

Yusen Shin-Yokohama 1-chome Bldg. **Taiwan** 1-7-9, Shin-Yokohama, Kohoku-ku Yokohama-shi, Kanagawa 222-0033 Japan Phone: +81-45-471-1021

Korea

RM 602, 6FL Korea City Air Terminal B/D, 159-6 Samsung-Dong, Kangnam-Gu, Seoul, 135-728, Korea Phone: +82-2-2016-6610 e-mail: koreasales@power.com

Singapore

51 Newton Road #19-01/05 Goldhill Plaza Singapore, 308900 Phone: +65-6358-2160 e-mail: singaporesales@power.com

5F, No. 318, Nei Hu Rd., Sec. 1 Nei Hu Dist. Taipei 11493, Taiwan R.O.C. Phone: +886-2-2659-4570 e-mail: taiwansales@power.com

UK

Building 5, Suite 21 The Westbrook Centre Milton Road **Cambridge** CB4 1YG Phone: +44 (0) 7823-557484 e-mail: eurosales@power.com

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Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный) **Факс:** 8 (812) 320-02-42 **Электронная почта:** org@eplast1.ru **Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.